

Search Notes

Application/Control No.

10/686,467

Examiner

Bao Q. Truong

Applicant(s)/Patent under
Reexamination

FUWAUSA ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Quick update text search with ultraviolet, quartz, and semiconductor	2/23/2006	BQT